

**Results of the EXAFS experiment ‘Determination of Er sites in Er-implanted silica containing Si nanocrystals by means of EXAFS spectroscopy’.**

**Samples:**

SiO<sub>x</sub> (x<2) + annealing + Er implant (5x10<sup>14</sup> Er<sup>+</sup>/cm<sup>2</sup>)+annealing (900°C, 1h)  
 (RT, 800°C, 1250°C)  
 (19A, 21A, 23A)

SiO<sub>2</sub> with Si nc + Er implant + annealing (900°C, 1h)  
 5.4x10<sup>19</sup> Er/cm<sup>3</sup> (137B)  
 2.1x10<sup>20</sup> Er/cm<sup>3</sup> (119A)  
 1.4x10<sup>21</sup> Er/cm<sup>3</sup> (121A)

The EXAFS experiment was performed at the Italian beamline GILDA of the European Synchrotron Radiation Facility at the Er L<sub>III</sub>-edge in fluorescence mode, cooling the samples at T=77K. The x-ray beam from a bending magnet was dynamically focused on the sample. The Er-L $\alpha$  fluorescence signal from the samples was recorded by a 13-element high-purity Ge detector.

**First shell analysis.**

All the recorded EXAFS spectra exhibit one main oscillation (see Fig. 1), related to the Er-O coordination. Correspondingly, in the Fourier transform moduli of the spectra (see Fig. 2) the peak of the first coordination shell (Er-O) is clearly visible at about R~1.5-2Å.

The first shell analysis was performed exploiting the FEFF8-FEFFTIT software package, fitting the first shell back-transformed signal (q-space), using the phase and amplitude calculated for the Er-O coordination of the Er<sub>2</sub>Si<sub>2</sub>O<sub>7</sub> model compound. In the Fig. 1, the comparison between the best-fitting curve and the experimental spectra is reported; the fitting results are collected in Table 1.

sample	N <sub>O</sub>	Er-O	
		R (Å)	$\sigma^2$ ( $\times 10^{-4} \text{Å}^2$ )
19A	2.2±0.4	2.05±0.01	60±27
21A	4.4±0.6	2.09±0.02	250±30
23A	3.5±0.5	2.10±0.02	189±30
137B	3.1±0.3	2.095±0.008	115±15
119A	5.8±0.2	2.161±0.003	240±7
121A	6.3±1.3	2.23±0.02	220±46
Er <sub>2</sub> O <sub>3</sub>			
site I	6	2.27	
site II	4	2.24	
	2	2.31	

It is found that:

- The Er-O coordination distance is always shorter than the corresponding average value for the crystalline  $\text{Er}_2\text{O}_3$ ; the largest value is  $R=2.23\text{\AA}$ , corresponding to the sample 121A.
- The coordination number is lower than that of the crystalline  $\text{Er}_2\text{O}_3$ , but for the 119A and 121A samples.
- There is a general correlation between the coordination number and the coordination distance, larger is the first, larger is the second (see Fig. 3).
- The effect of heating the substrate before the Er implantation is to increase the coordination number of O atoms around Er.
- The effect of increasing the Er implantation dose is to increase the coordination number of O atoms around Er.
- In Fig. 3 the results obtained (the red line is a guideline for the eye) are compared with those in literature for Er-implanted silica (Marcus et al, JNCS 91 and JNCS 96). Marcus et al. (JNCS96) found that in Er-implanted silica (flat-top profile,  $E\sim 5\text{MeV}$ , top concentration = 1at%), the effect of annealing in vacuo ( $T=900\text{C}$ , 1h) is to increase the coordination number and the Er-O average distance from  $N=2.2$ ,  $R=2.11\text{\AA}$  (marker c, Fig. 3) towards  $N=6.3$ ,  $R=2.24\text{\AA}$  (marker d, Fig. 3). The same annealing did not turn out in significant structural modification if the Er concentration is lower (0.1at%, markers a and b).

### **Second shell analysis.**

In most all the spectra a second shell is visible, located at about  $R=3\text{\AA}$ . The analysis of the signal from the first two shells was based on the GNXAS code, considering a model for the Er site in which each first-shell O atom is bonded with a Si atom in a typical  $\text{SiO}_2$  tetrahedron. In the fitting, both the single scattering signals (Er-O and Er-Si) and the three-atoms scattering signal (from the Er-O-Si triangle) was considered. This model reproduces the experimental data of the samples 19A, 137B and 121A, as shown in Fig. 4.

Possible Er-Er coordination, if present, is below the detectable limit.

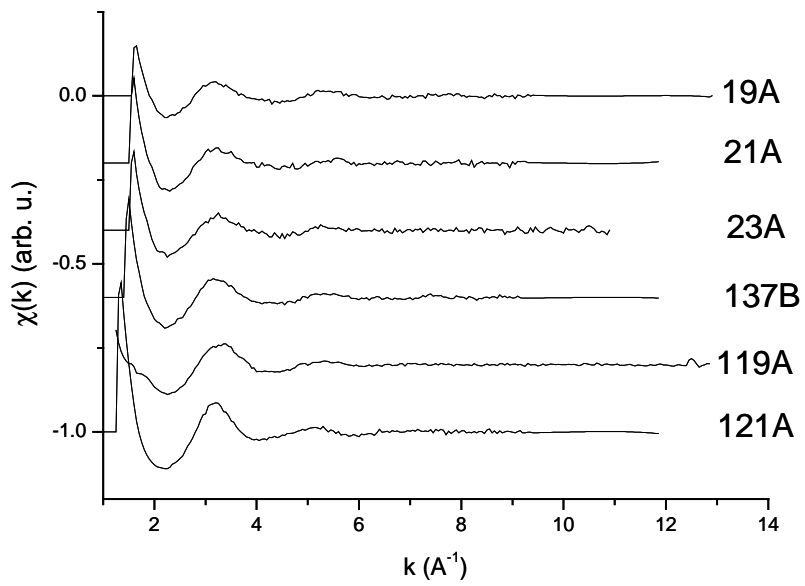


Fig. 1

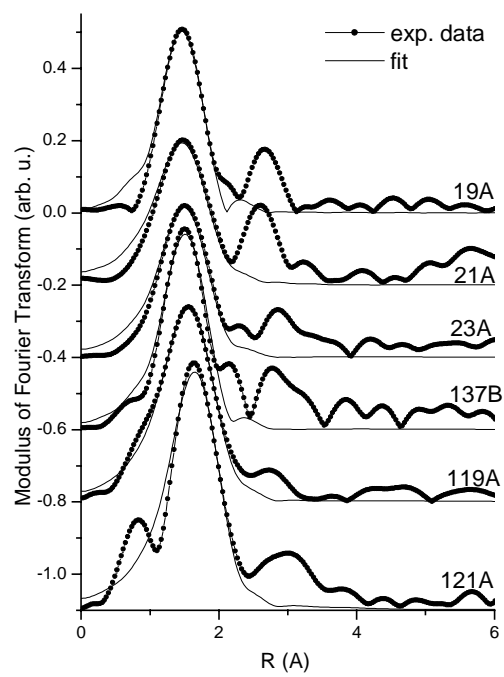


Fig. 2

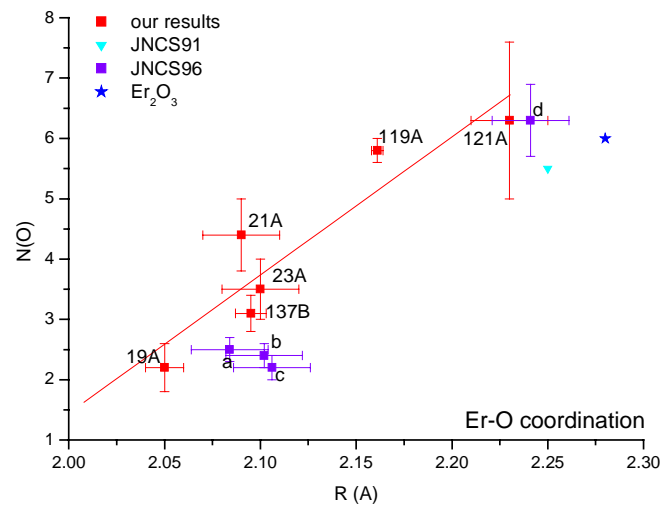


Fig. 3